

**Notice of References Cited**

Application/Control No.

09/691,219

Applicant(s)/Patent Under  
Reexamination  
WEI ET AL.

Examiner

Michael Pak

Art Unit

1646

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 2002/22684	03-2002	WO	Lee et al.	—
	O					
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**NON-PATENT DOCUMENTS**

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